# **MOSFET** - Power, Single N-Channel, TOLL 80 V, 1.05 mΩ, 351 A

## **NVBLS1D1N08H**

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- Lowers Switching Noise/EMI
- These Devices are Pb-Free and are RoHS Compliant

## **Typical Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltage			$V_{DSS}$	80	V
Gate-to-Source Voltage	9		$V_{GS}$	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	351	Α
Current R <sub>θJC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C		248	
Power Dissipation	State	T <sub>C</sub> = 25°C	$P_{D}$	311	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		156	
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	41	Α
Current R <sub>0JA</sub> (Notes 1, 2, 3)		T <sub>A</sub> = 100°C		29	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	4.2	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		2.1	
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	259	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 31.9 A)			E <sub>AS</sub>	1580	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.48	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	35.8	

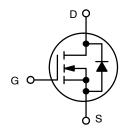
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



## ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	1.05 m $\Omega$ @ 10 V	351 A



**N-CHANNEL MOSFET** 



TOLL CASE 100CU

## **MARKING DIAGRAM**



NVBLS1D1N08H = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

ZZ = Lot Traceability

## **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				57		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	T <sub>J</sub> = 25 °C			10	μΑ
		$V_{DS} = 80 \text{ V}$	T <sub>J</sub> = 125°C			250	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 650 μΑ	2.0	2.9	4.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-7.7		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		0.92	1.05	mΩ
Forward Transconductance	9 <sub>FS</sub>	$V_{DS} = 5 \text{ V}, I_{D}$	= 50 A		213		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C <sub>ISS</sub>			11200		pF	
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 40 V			1600		
Reverse Transfer Capacitance	C <sub>RSS</sub>				49		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 64 V; I <sub>D</sub> = 50 A			166		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				29		
Gate-to-Source Charge	Q <sub>GS</sub>				44		
Gate-to-Drain Charge	$Q_{GD}$				35		
Plateau Voltage	$V_{GP}$				4		V
SWITCHING CHARACTERISTICS (Note 5	5)						
Turn-On Delay Time	t <sub>d(ON)</sub>				45		
Rise Time	t <sub>r</sub>	VG9 = 10 V. Vn	s = 64 V.		43		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 10 \text{ V}, V_{D}$ $I_{D} = 50 \text{ A}, R_{G}$	$_{\rm i}$ = 6 $\Omega$		141		
Fall Time	t <sub>f</sub>				43		1
DRAIN-SOURCE DIODE CHARACTERIS	STICS						•
Forward Diode Voltage	$V_{SD}$	$V_{SD}$ $V_{GS} = 0 \text{ V},$ $I_{S} = 50 \text{ A}$	T <sub>J</sub> = 25°C		0.76	1.2	
			T <sub>J</sub> = 125°C		0.6		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 50 A			92		ns
Reverse Recovery Charge	Q <sub>RR</sub>				234		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

5. Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**

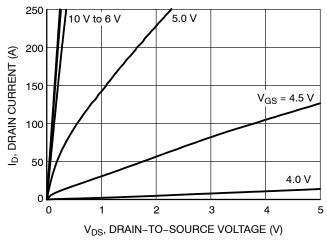
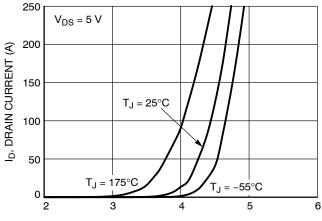


Figure 1. On-Region Characteristics



V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics

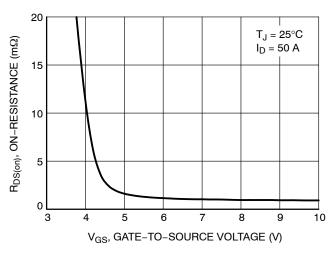


Figure 3. On-Resistance vs. Gate-to-Source Voltage

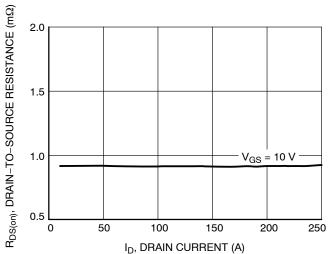


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

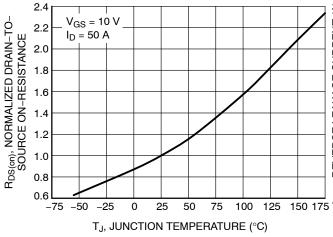


Figure 5. On–Resistance Variation with Temperature

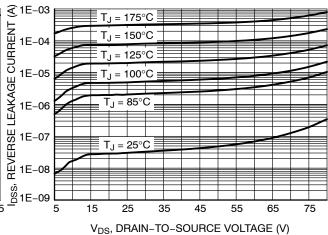


Figure 6. Drain-to-Source Leakage Current vs. Voltage

## **TYPICAL CHARACTERISTICS**

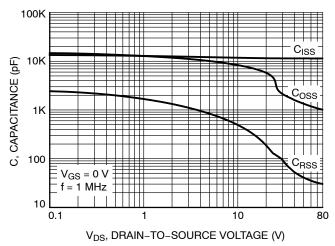


Figure 7. Capacitance Variation

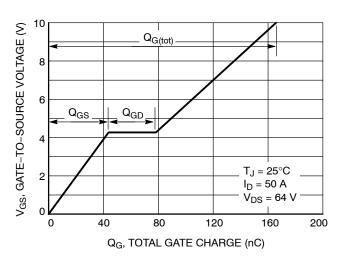


Figure 8. Gate-to-Source Voltage vs. Total Charge

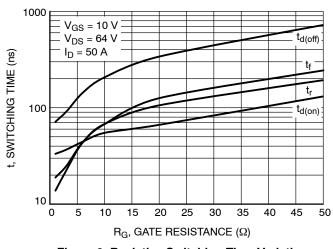


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

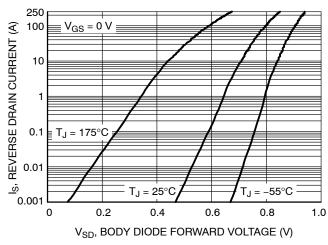


Figure 10. Diode Forward Voltage vs. Current

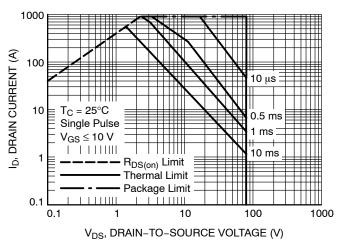


Figure 11. Maximum Rated Forward Biased Safe Operating Area

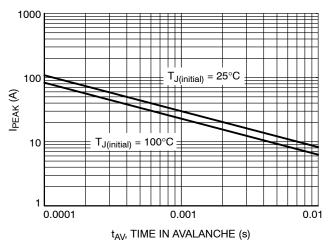


Figure 12. Maximum Drain Current vs. Time in Avalanche

## **TYPICAL CHARACTERISTICS**

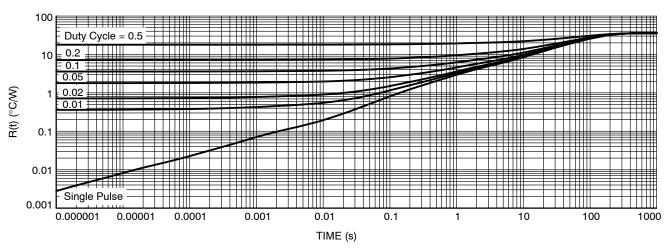
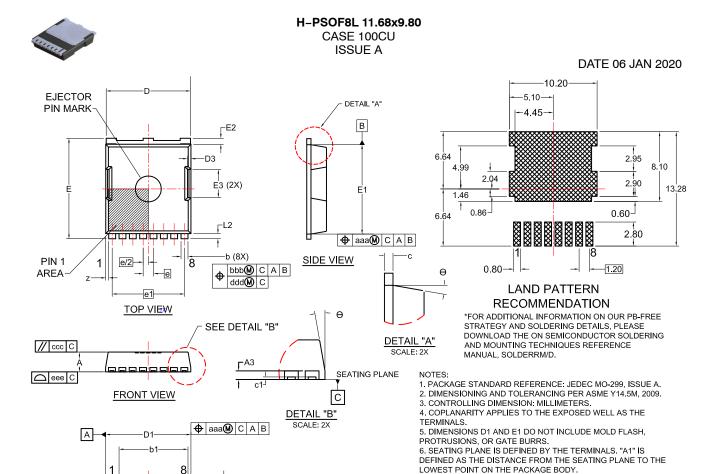


Figure 13. Transient Thermal Impedance

## **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVBLS1D1N08H	NVBLS 1D1N08H	M0-299A (Pb-Free)	2000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



DIM	MILLIMETERS				
5	MIN.	NOM.	MAX.		
Α	2.20	2.30	2.40		
A3	0.40	0.50	0.60		
b	0.70	0.80	0.90		
b1	8.00 REF				
С	0.40	0.50	0.60		
c1	0.10				
D	9.70	9.80	9.90		
D1	9.80	9.90	10.00		
D2	4.73 BSC				
D3	0.40 REF				
D4	3.75 BSC				
D5	_	1.20			
D6	7.40	7.50	7.60		
D7	(8.30)				
E	11.58	11.68	11.78		
E1	10.28	10.38	10.48		
E2	0.60	0.70	0.80		
E3	3.30 REF				

E4

DIM	MILLIMETERS				
Divi	MIN.	NOM.	MAX.		
е	1.20 BSC				
e/2	(	0.60 BSC	;		
e1		3.40 BSC	;		
K	1.50	1.57	1.70		
L	1.90	2.00	2.10		
L2	0.50	0.60	0.70		
Z	0.35 REF				
θ	0°		12°		
aaa	0.20				
bbb	0.25				
ccc	0.20				
ddd	0.20				
eee	0.10				
E5	-	3.30	_		
E6		0.65	_		
E7	7.15 REF				
E8	6.55	6.65	6.75		
E9	5.89 BSC				
E10	5.19 BSC				

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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H.H.H.H.H.H

|--D5 (3X)

D4 -

-D7

**BOTTOM VIEW** 

E10

E9

| E8

L

-0.10 E4 (2X)

E5 (2X) ⊢E6 (2X)

Α

WW

ZΖ

GENERIC
MARKING DIAGRAM\*

AYWWZZ

XXXXXXXX

= Year

= Work Week

XXXX = Specific Device Code

= Assembly Location

= Assembly Lot Code

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